## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | WANG, TSE-HSIEN | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,151,356	11-2000	Spagnoletti et al.	375/226
	В	US-5,406,335	04-1995	Nikoh, Hidemitsu	348/642
	С	US-6,330,391	12-2001	Kurihara et al.	386/21
	D	US-4,797,730	01-1989	Smith, Terrance	348/539
	Е	US-4,476,558	10-1984	Arnon, Ephraim	370/294
	F	US-			
	G	US-			
	Н	US-			
	T	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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